

# **Dynamic Matching and Mismatch Shaping**

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## DATA CONVERTERS

Typical A/D and D/A converters rely on the accurate matching of analog elements and/or ideal amplifier performance.

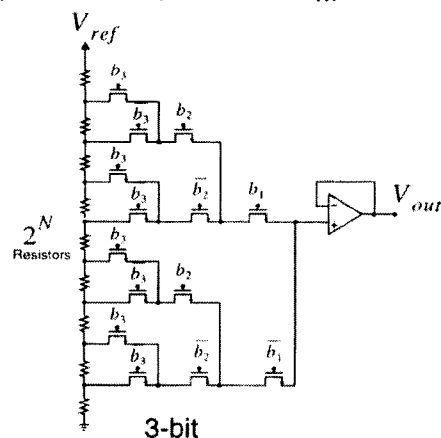
Examples:

- R-STRING DAC
- CURRENT-MODE DAC
- SC DAC
- FLASH ADC
- CHARGE-REDISTRIBUTION ADC

## DATA CONVERTERS

### RESISTOR-STRING DAC

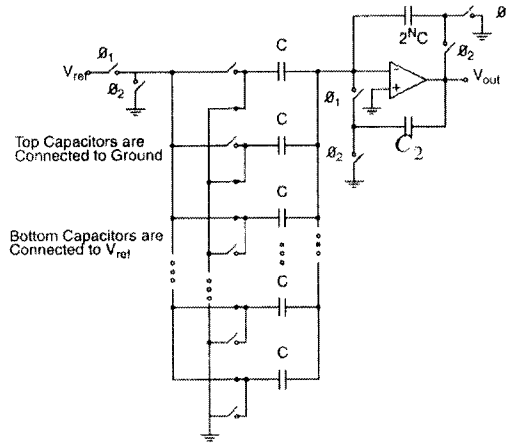
Monotonic, but for  $N$  bits an  $\text{INL} = 0.5 \text{ LSB}$  requires a matching accuracy of  $\Delta R/R < 2^{-N}$ . For 0.2% matching,  $N = 9$ .



## DATA CONVERTERS

### SWITCHED-CAPACITOR DAC

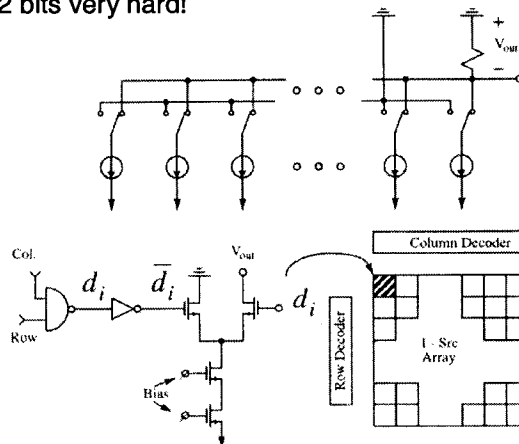
Monotonic, but input caps must be matched so that  $\Delta C/C < 2^{-N-1}$  for sufficient linearity. Opamp gain must be very high for large N!



## DATA CONVERTERS

### CURRENT-MODE DAC

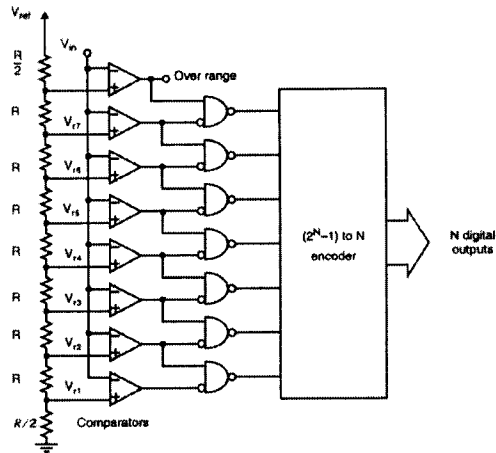
Current sources must be matched to  $2^{-N-1}$  relative accuracy. 10 bits possible; 12 bits very hard!



## DATA CONVERTERS

### FLASH ADC

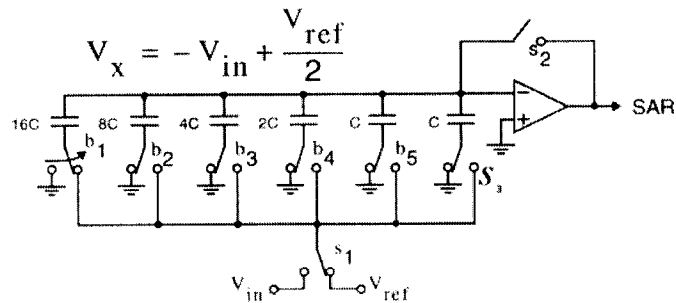
$\Delta R/R < 2^{-N}$  required for N-bit resolution.



## DATA CONVERTERS

### CHARGE-REDISTRIBUTION ADC

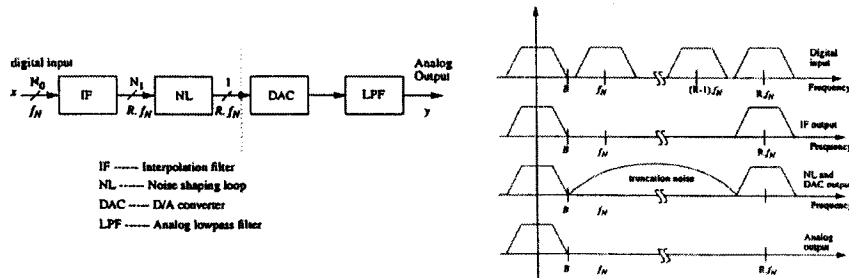
For  $INL = 0.5$  LSB,  $\Delta C/C < 2^{-N}$  required. Limited to 11-12 bits.



## DATA CONVERTERS

### DELTA-SIGMA DACS

They use digital preprocessing (oversampling & noise-shaped truncation) to produce a fast, low-resolution (often 1-bit) input signal for the actual DAC:

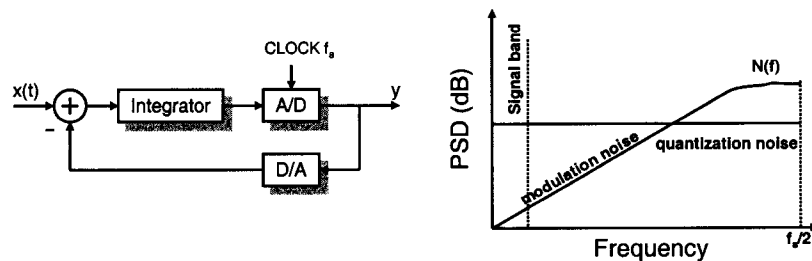


1-bit DAC is (ideally) absolutely linear! Analog postfilter difficult.

## DATA CONVERTERS

### DELTA-SIGMA ADCS

Analog loop generates oversampled noise-shaped low-resolution (often 1-bit) digital output, allows linear DAC operation:



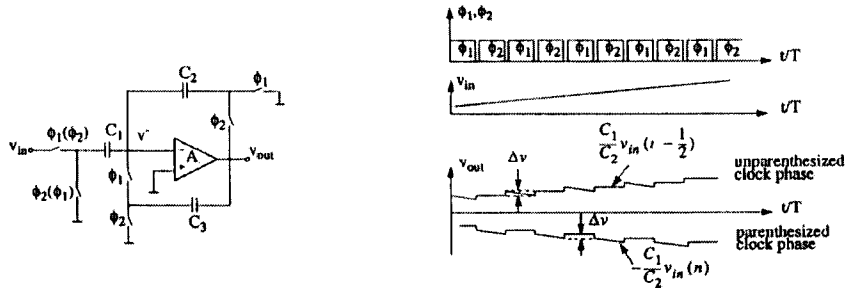
Loop design difficult, but ENOB > 20 has been achieved. Covered in *Delta-Sigma Data Converters*, S. Norsworthy, R. Schreier, G. Temes, Eds., IEEE Press, 1997.

## CORRECTION TECHNIQUES

### CORRELATED DOUBLE SAMPLING

Noise (1/f, offset, vestigial signal) is stored and subtracted.

Example: SC amplifier:

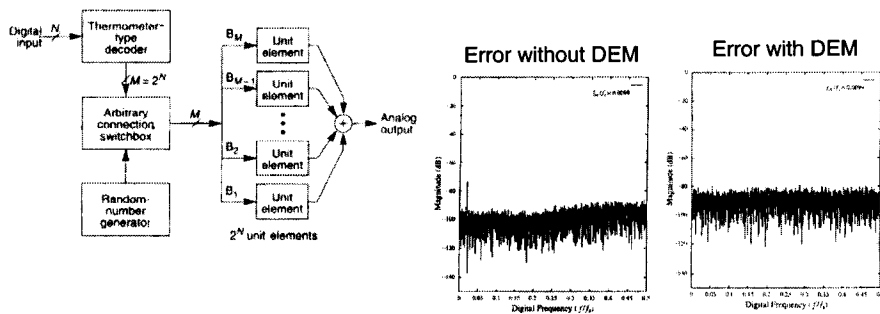


During reset ( $\Phi_1 = 1$ )  $C_1$  &  $C_2$  store virtual ground voltage. Result: offset cancelled, 1/f noise and input signal high-pass filtered, gain boosted, THD reduced.

## CORRECTION TECHNIQUES

### DYNAMIC MATCHING (ELEMENT SCRAMBLING)

Static nonlinearity causes distortion. To decorrelate the DAC error from the signal, dithering can be used. It occupies some of the signal range, and hence reduces the dynamic range. Better: randomize the unit element selection.

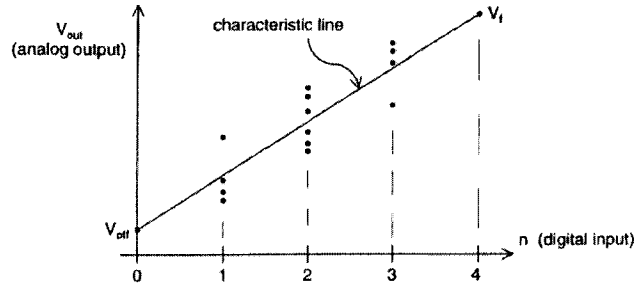


Harmonics converted to random noise. (0.1% DAC error assumed.)

## SPECTRAL ERROR SHAPING

Instead of correcting or cancelling the error signal generated by mismatch, it can be filtered out of the signal band, just as the quantization error is in the delta-sigma converter.

Example: 4-level SC DAC with input capacitor mismatch. If every choice of the input capacitors corresponding to each code is plotted, the result may be as shown:



Note: The average of outputs falls on the characteristic line. Hence, if each combination is used equally often, the average codes will give a linear operation.

## SPECTRAL ERROR SHAPING

Simple techniques:

- **Barrel shifting** - start each new conversion one index higher;
- **Individual level averaging** - keep track of all past conversions, make average usage of each element the same;
- **Data-weighted averaging** - start where the previous conversion ended. Wrap-around after the last  $C_{IN}$  was used.

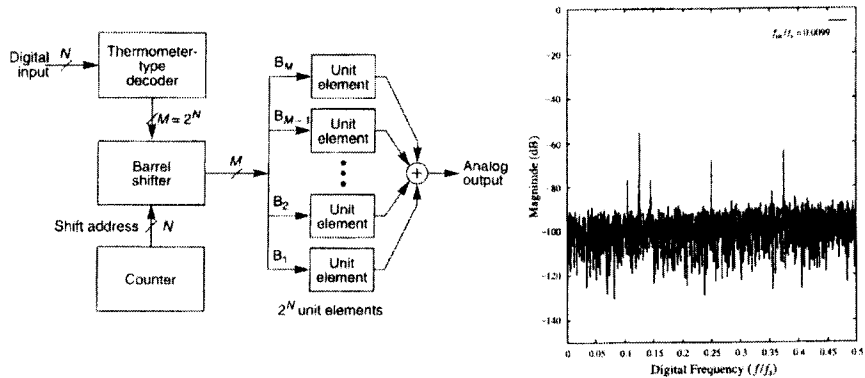
This introduces a  $(z - 1)$  highpass factor into the noise transfer function  $\Rightarrow$  first-order noise shaping.

To achieve second-order noise shaping,  $M$  second-order digital delta-sigma loops may be used to derive the element selection sequence.

## SPECTRAL ERROR SHAPING

### BARREL SHIFTING ALGORITHM

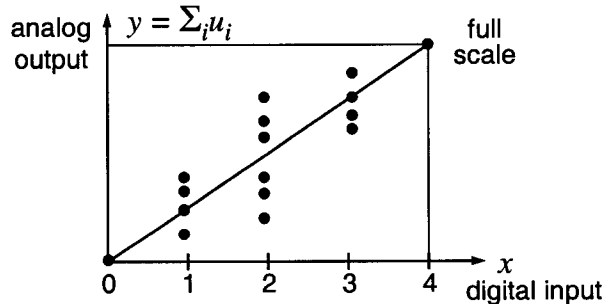
Modulates the mismatch noise. Can be combined with randomization. Will generate tones due to mixing of noise, signal and modulation carrier.



## SPECTRAL ERROR SHAPING

### INDIVIDUAL LEVEL AVERAGING

Since the mean of all possible outputs for a given input code falls on the ideal curve, by keeping track of previous element choices for each code and selecting them sequentially, the average (ideal result) will be approached eventually, but after a longer time than in DWA. Various algorithms are available to implement it.

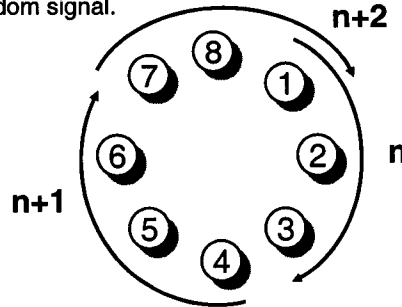




## SPECTRAL ERROR SHAPING

### DATA-WEIGHTED AVERAGING

The elements are selected sequentially, so the difference in the # of usage is  $< 1$ . Assuming that the sum of all errors  $\delta_i$  is zero, the max. accumulated error  $s(p)$  after  $p$  periods is just the sum of all positive or negative errors among the elements.  $s(p)$  is strictly bounded at a relatively small value  $M$ . The average value is  $M/p \rightarrow 0$ , as  $p \rightarrow \infty$ . The error made in the  $n^{\text{th}}$  period is  $e(n) = s(n) - s(n - 1)$ , hence the error power spectral density (PSD) is  $PSD_e = |1 - z^{-1}|^2 \cdot PSD_s$ . If the input is busy and random,  $s(n)$  is a bounded random white noise, and hence  $e(n)$  will be a lowpass-filtered (shaped) random signal.



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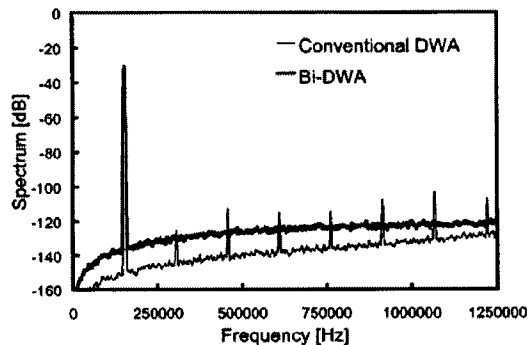
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## SPECTRAL ERROR SHAPING

### TONE GENERATION IN DWA

If the input is DC or varies slowly, and there is a rational relation between its value and the # of elements, tones will be generated in  $e(n)$ . They can be eliminated by introducing a random component into the element selection logic. This is similar to dither, but doesn't reduce the dynamic range. For alternating rotation, the tones disappear:



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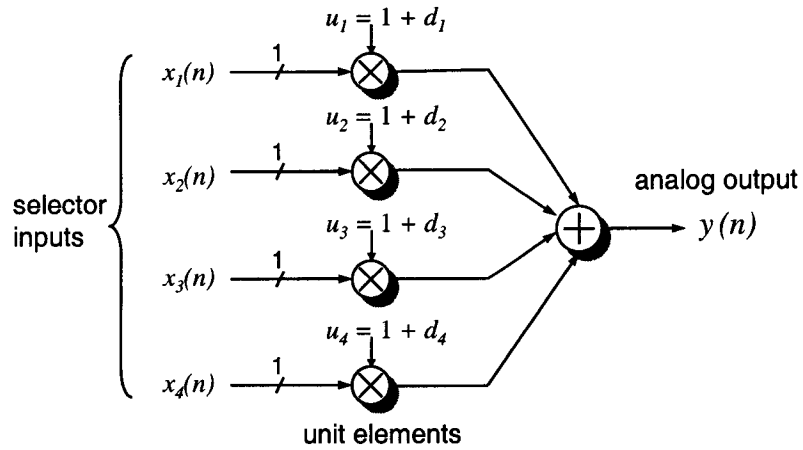
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## SPECTRAL ERROR SHAPING

### DELTA-SIGMA ELEMENT SELECTION SCHEME I

#### 5-level DAC



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## SPECTRAL ERROR SHAPING

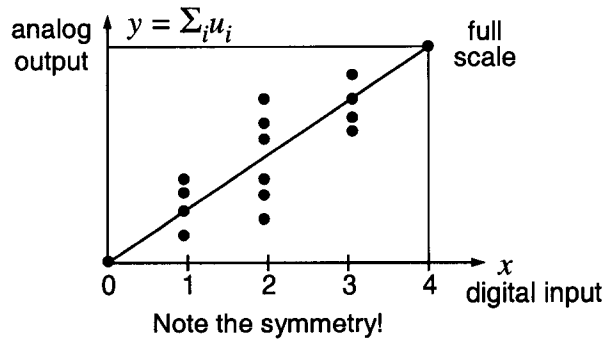
### DELTA-SIGMA ELEMENT SELECTION SCHEME II

#### Assumption

We accept the full-scale DAC output as accurate.  
Then:

$$d_1 + d_2 + \dots + d_N = 0$$

and the ideal element value is the average of all element values.



Note the symmetry!

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## SPECTRAL ERROR SHAPING

### DELTA-SIGMA ELEMENT SELECTION SCHEME III

#### Conditions on the Selector Sequences

1. All  $x_i(n)$  values are 0 or 1
2.  $\sum_i x_i(n) = v(n)$  = digital output of the  $\Delta\Sigma$  loop
3. Each input can be written as:

$$x_i(n) = f(n) + h(n) * e_i(n),$$

where  $f(n)$  is a bounded function;

$Z[h(n)] = H(z) = (1 - z^{-1})^m$ , a high-pass filter function;

and  $e_i(n)$  is a bounded pseudo-random signal.

Note that  $f(n)$  and  $h(n)$  are the same for all  $x_i$ , and the order  $m$  is 1 or 2.

## SPECTRAL ERROR SHAPING

### DELTA-SIGMA ELEMENT SELECTION SCHEME IV

#### The Shaped DAC Output Signal

Clearly

$$y(n) = \sum_i x_i(n)(1+d_i)$$

$$y(n) = v(n) + \sum_i [f(n) + h(n) * e_i(n)] d_i$$

$$y(n) = v(n) + 0 + h(n) * \sum_i d_i e_i(n)$$

Thus, the DAC error is high-pass filtered, as required for mismatch shaping.

## SPECTRAL ERROR SHAPING

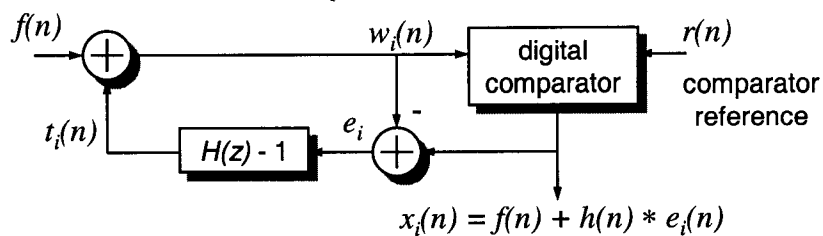
### DELTA-SIGMA ELEMENT SELECTION SCHEME V

#### The Generation of the Selector Sequences

Each  $x_i(n)$  can be obtained as the output of a digital  $\Delta\Sigma$  loop, with an input  $f(n)$  and truncation error  $e_i(n)$ .

Using the error-feedback configuration, the  $i$ th loop is of the form:

$$x_i = \begin{cases} 1 & \text{if } w_i(n) \geq r(n) \\ 0 & \text{if } w_i(n) < r(n) \end{cases}$$



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## SPECTRAL ERROR SHAPING

### DELTA-SIGMA ELEMENT SELECTION SCHEME VI

#### The Choice of $r(n)$ and $f(n)$

In each step,  $r(n)$  is adjusted so that  $v(n)$  of the  $x_i(n)$  will be 1, the rest 0. In practice, the  $x_i$  outputs of  $v(n)$  loops with the largest  $w_i(n)$  will be simply set to 1, the rest to 0. This will minimize  $\sum_i x_i(n)e_i^2(n)$ , and thus the mismatch noise power.

Also, choosing  $f(n) = -\min_i [t_i(n)]$  will minimize  $\sum_i w_i^2(n)$  and will keep it bounded.

The system can also be used as the feedback DAC of a  $\Delta\Sigma$  ADC loop.

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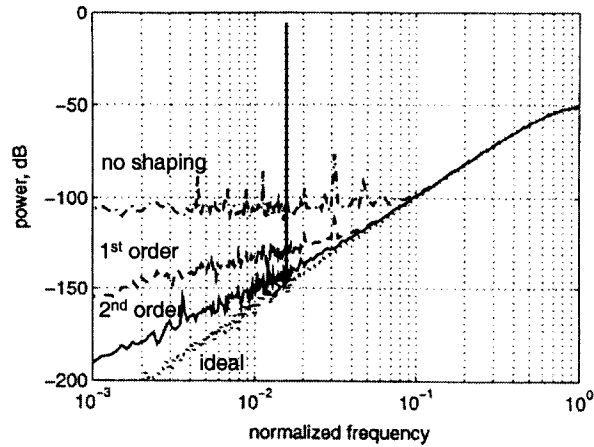
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## SPECTRAL ERROR SHAPING

### DELTA-SIGMA ELEMENT SELECTION SCHEME VII

#### Example: Third-Order $\Delta\Sigma$ ADC



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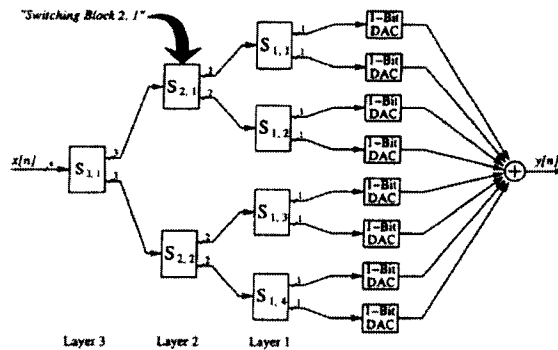
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## SPECTRAL ERROR SHAPING

### TREE STRUCTURE SCHEME I

#### Number Conservation Rule



Each switching block satisfies the *number conservation rule*:

1. The SB output  $\in \{0, 1, \dots, 2^{k-1}\}$ , where  $k$  is the layer number
2. The sum of the SB's outputs equals the SB's input

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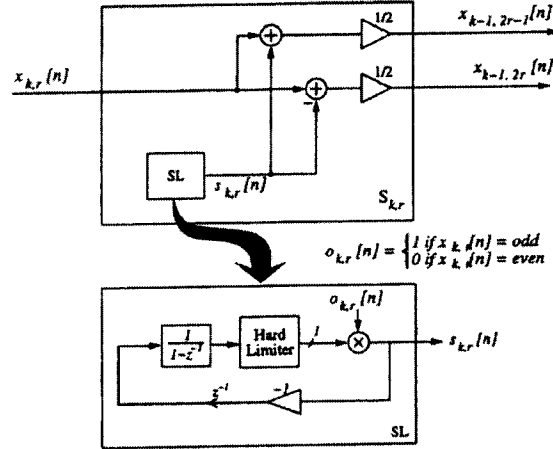
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# SPECTRAL ERROR SHAPING

## TREE STRUCTURE SCHEME II

### 1st-order Switching Block DSP



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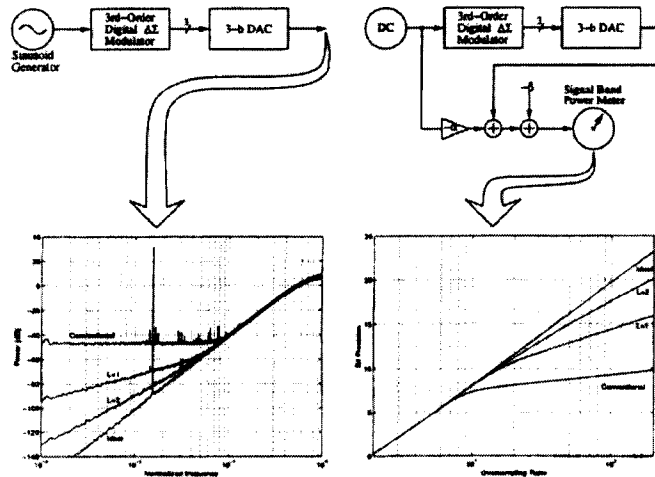
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# SPECTRAL ERROR SHAPING

## TREE STRUCTURE SCHEME III

### Example Simulations



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## OTHER CORRECTION TECHNIQUES

For making matching suitable for ENOB > 10 bits.

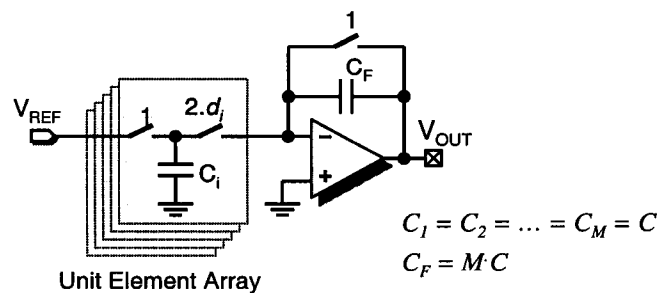
Techniques:

1. Digitally Controlled Analog Correction
2. Digital Correction
3. Digitally Controlled Analog Error Cancellation
4. Spectral Error Filtering

## OTHER CORRECTION TECHNIQUES

### ANALOG CORRECTION I

*M*-level switched-capacitor DAC with thermometer-coded input:

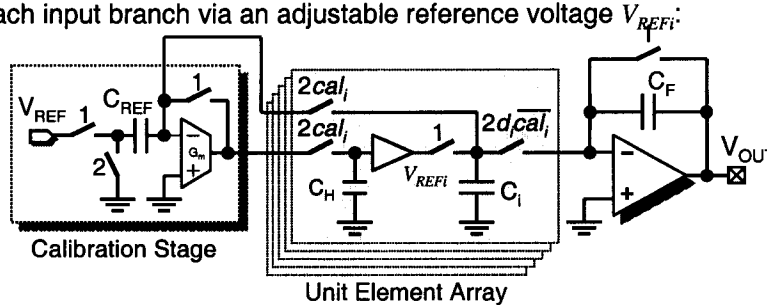


Unit-element charge input; less sensitive to mismatch, better DNL, guaranteed monotonicity, reduced glitch noise. Still, hard to get over 10-bit linearity and accuracy.

## OTHER CORRECTION TECHNIQUES

### ANALOG CORRECTION II

To improve accuracy & linearity, provide a “fine” adjustment of the charge in each input branch via an adjustable reference voltage  $V_{REFi}$ :

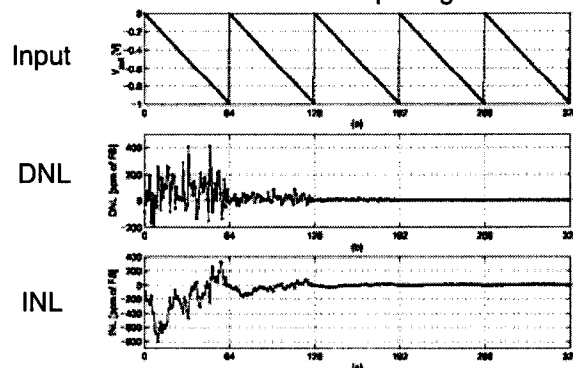


The calibration stage compares the stored charge in each branch with the desired exact charge  $V_{REF} C_{REF}$ , iteratively corrects charge error. The process is insensitive to the offset of the  $G_M$  and charge injection mismatch. For  $M$  nonzero levels,  $M+1$  branches are needed. The opamp needs CDS to eliminate the error signals at its input.

## OTHER CORRECTION TECHNIQUES

### ANALOG CORRECTION III

**Example:** 6-bit (64-level) DAC, with 1% rms random capacitance mismatch and full-scale sawtooth input signal.



Without correction (first cycle),  $INL = 1.65\%$  of LSB,  $DNL = 0.83\%$  of LSB.  
 After convergence (4th cycle)  $INL = 0.024\%$  of LSB,  $DNL = 0.0046\%$  of LSB  $\cong 1.6$  ppm  $\approx 19$  ENOB.